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| Notice of References Cited | Application/Control No. 10/080,589 | Applicant(s)/Patent Under Reexamination YONEDA, TADAAKI | |
| | Examiner Lin Ye | Art Unit 2615 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,477,332 | 11-2002 | Ohsawa, Toshifumi | 396/319 |
| | B | US-2001/0050875 | 12-2001 | Kahn et al. | 365/229 |
| | C | US-6,226,449 | 05-2001 | Inoue et al. | 386/120 |
| | D | US-6,470,413 | 10-2002 | Ogawa, Takeshi | 711/103 |
| | E | US-6,396,744 | 05-2002 | Wong, Sau Ching | 365/185.25 |
| | F | US-5,845,166 | 12-1998 | Fellegara et al. | 396/429 |
| | G | US-6,834,130 | 12-2004 | Niikawa et al. | 382/305 |
| | H | US-6,657,667 | 12-2003 | Anderson, Eric C. | 348/333.12 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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